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Complete if Known Substitute for form 1449A/PTO **Application Number** 10/789,319 INFORMATION DISCLOSURE **Filing Date** 02/27/2004 STATEMENT BY APPLICANT Xu et al. First Named Inventor 1712 **Group Art Unit** (use as many sheets as necessary) Zimmer, Marc S. **Examiner Name** 25 of Sheet **Attorney Docket Number** P121-63-03

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^{*}Unique chatton designation number. *See attached Kinds of U.S. Patent Documents. *Enter Office that issued the document, by the two-latter code (WIPO Standard ST.3). *For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. *Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. *Applicant is to place a check mark here if English language Translation is attached.

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ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

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Title of Invention

COMPOSITION FOR AN ETCHING MASK COMPRISING A SILICON-CONTAINING MATERIAL

Application Number:

10/789319

Confirmation Number:

9202

First Named Applicant:

Frank Xu

Attorney Docket Number:

P121-63-03

Art Unit:

1712

Examiner:

Marc S. Zimmer

Search string:

(6468642 or 5542978 or 5837314 or 6565776 or 6503914 or 6649272 or 6204343

or 4614667 or 3810874 or 6737489 or 6721529 or 6664306 or 6790905 or 6544594

or 6774183 or 6830819 or 6802870 or 5389696).pn

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

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				Application Number	10/789,319	
INFORMATION DISCLOSURE				Filing Date	02/27/2004 .	
STATEMENT BY APPLICANT			PLICANT	First Named Inventor	Xu et al.	
				Group Art Unit	1712	
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Sheet	21	of ·	25	Attorney Docket Number	P121-63-03	

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Examiner Initials*	Cita No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Ť
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¹Unique citation designation number. ²Applicant is to place a check mark here il English language Translation is attached.

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Substitute for form 1449B/PTO				Complete if Known		
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INFO	RMATION	N DISCI	LOSURE	Filing Date	02/27/2004	
STATEMENT BY APPLICANT			LICANT	First Named Inventor	Xu et al.	
				Group Art Unit	1712	
(use as many sheets as necessary)			essary)	Examiner Name	Zimmer, Marc S.	
Sheet	18	of	25	Attorney Docket Number	P121-63-03	

		ION PATENT LITERATURE DOCUMENTS Include name of the author (in CAPITAL LETTERS), title of the cricie (when appropriate), title of the	
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^{*}Unique citation designation number. *Applicant is to place a check mark here if English language Translation is attached.

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Substitute for form 14498/PTO				Complete If Known		
				Application Number	10/789,319	
INFO	RMATIO	N DISCI	LOSURE	Filing Date ·	02/27/2004	
STATEMENT BY APPLICANT (use as many sheets as necessary)			PLICANT	First Named Inventor	Xu et al.	
				Group Art Unit	1712	
			essary)	Examiner Name	Zimmer, Marc S.	
Sheet	16	of	25	Attorney Docket Number	P121-63-03	

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Examiner Signature	muse Jeanney	Date Considered	64 105	
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